Q1PACK Module

This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

Features

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Q1PACK Package with Press-Fit and Solder Pins

Typical Applications

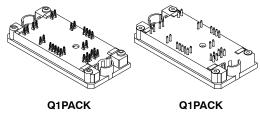
- Solar Inverters
- Uninterruptable Power Supplies



ON Semiconductor®

www.onsemi.com



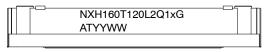


CASE 180AD PRESS FIT

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Q1PACK CASE 180AQ SOLDER PINS

DEVICE MARKING

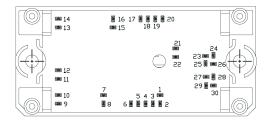




G = Pb-Free Package

AT = Assembly & Test Site Code YYWW = Year and Work Week Code

PIN ASSIGNMENTS



ORDERING INFORMATION

See detailed ordering and shipping information on page 14 of this data sheet.

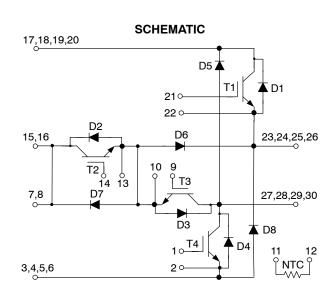


Table 1. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
HALFBRIDGE IGBT INVERSE DIODE (D1, D4)			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Forward Current, DC @ T _h = 80°C	١ _F	20	А
Repetitive Peak Forward Current T _{pulse} limited by T _{jmax}	I _{FRM}	80	A
$\begin{array}{l} \mbox{Power Dissipation per Diode} \\ \mbox{T}_{j} = \mbox{T}_{jmax} & \mbox{T}_{h} = 80^{\circ}\mbox{C} \end{array}$	P _{tot}	51	W
Maximum Junction Temperature	TJ	150	°C
HALFBRIDGE IGBT (T1, T4)			-
Collector-emitter voltage	V _{CES}	1200	V
Collector current @ T _h = 80°C	Ι _C	140	А
Pulsed Collector Current, T _{pulse} Limited by T _{jmax}	I _{CM}	480	А
$\begin{array}{l} \mbox{Power Dissipation per IGBT} \\ \mbox{T}_{j} = \mbox{T}_{jmax} & \mbox{T}_{h} = 80^{\circ}\mbox{C} \end{array}$	P _{tot}	280	W
Gate-emitter voltage	V _{GE}	±20	V
Short Circuit Withstand Time V_{GE} = 15 V, V_{CE} = 600 V, T_J \leq 150°C	T _{SC}	10	μs
Maximum Junction Temperature	TJ	150	°C
NP DIODE (D6, D7)			-
Peak Repetitive Reverse Voltage	V _{RRM}	650	V
Forward Current, DC @ T _h = 80°C	l _F	58	А
Repetitive Peak Forward Current, T _{pulse} limited by T _{Jmax}	I _{FRM}	200	А
$\begin{array}{l} \text{Power Dissipation Per Diode} \\ T_j = T_{jmax} & T_h = 80^{\circ}\text{C} \end{array}$	P _{tot}	89	W
Maximum Junction Temperature	TJ	150	°C
NP IGBT (T2, T3)			
Collector-emitter voltage	V _{CES}	650	V
Collector current @ $T_h = 80^{\circ}C$	Ι _C	83	А
Pulsed collector current, T_{pulse} limited by T_{Jmax}	I _{CM}	235	А
$\begin{array}{l} \text{Power Dissipation Per IGBT} \\ T_{j} = T_{jmax} & T_{h} = 80^{\circ}\text{C} \end{array}$	P _{tot}	117	W
Gate-emitter voltage	V _{GE}	±20	V
Short Circuit Withstand Time V_{GE} = 15 V, V_{CE} = 400 V, T_J \leq 150°C	T _{sc}	5	μs
Maximum Junction Temperature	TJ	150	٥°
NP INVERSE DIODE (D2, D3)			
Peak Repetitive Reverse Voltage	V _{RRM}	650	V
Forward Current, DC @ T _h = 80°C	١ _F	17	А
Repetitive Peak Forward Current, T_{pulse} limited by T_{Jmax}	I _{FRM}	68	А
Power Dissipation Per Diode $T_j = T_{jmax}$ $T_h = 80^{\circ}C$	P _{tot}	28	W
Maximum Junction Temperature	TJ	150	°C
HALFBRIDGE DIODE (D5, D8)			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Forward Current, DC @ T _h = 80°C (per diode)	l _F	45	А
Repetitive Peak Forward Current, T _{pulse} limited by T _{Jmax}	I _{FRM}	180	А
Power Dissipation Per Diode $T_j = T_{jmax}$ $T_h = 80^{\circ}C$	P _{tot}	78	W

Table 1. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
HALFBRIDGE DIODE (D5, D8)			
Junction Temperature	Т _Ј	150	°C
THERMAL PROPERTIES			
Operating Temperature under switching condition	T _{VJ OP}	–40 to (T _{jmax} –25)	°C
Storage Temperature range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60 Hz/50 Hz	V _{is}	3000	V _{RMS}
Creepage distance		12.7	mm
Clearance		8.06	mm

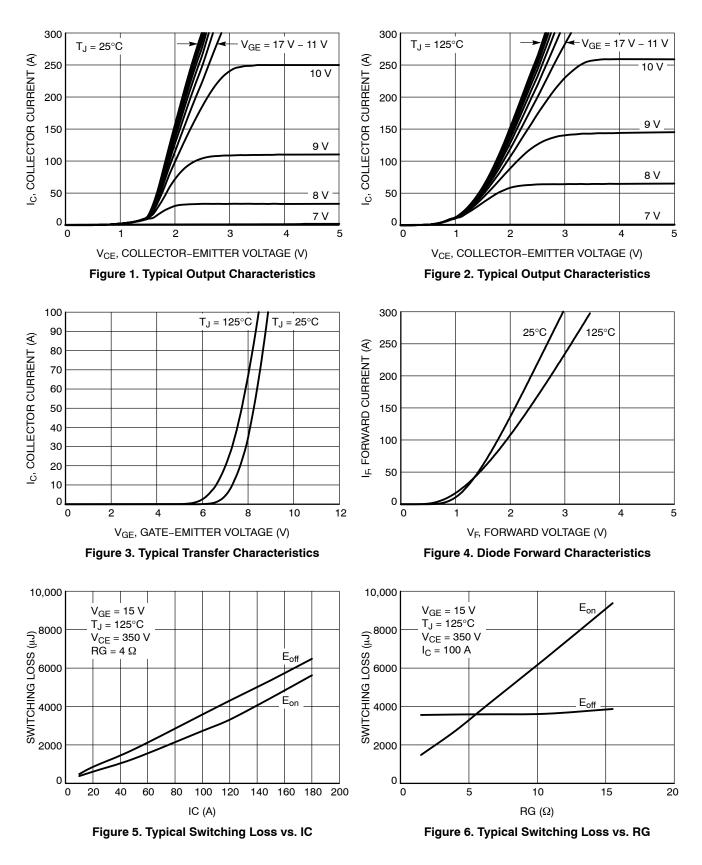
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

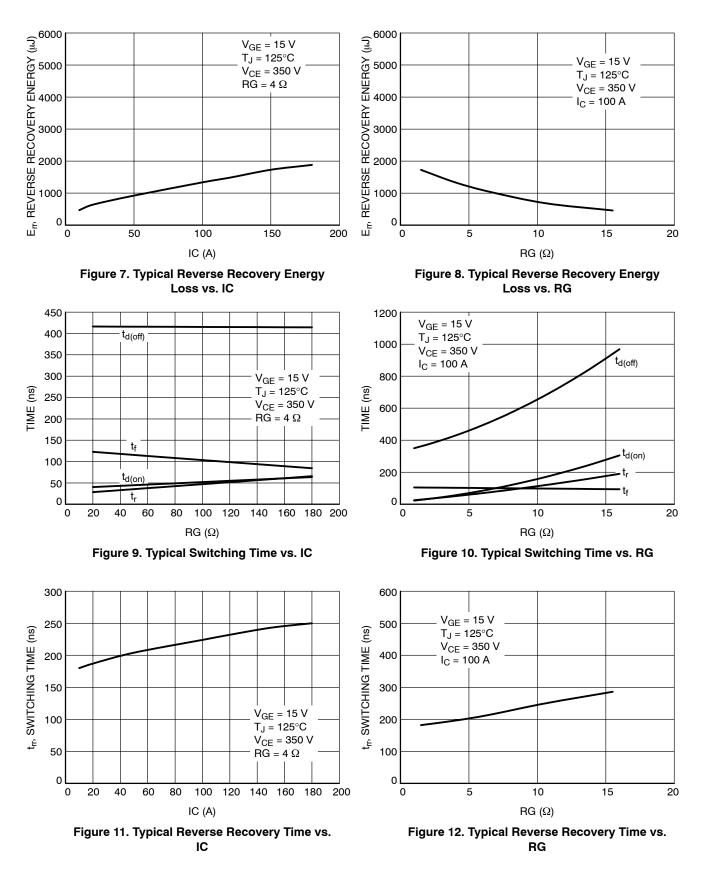
Table 2. ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

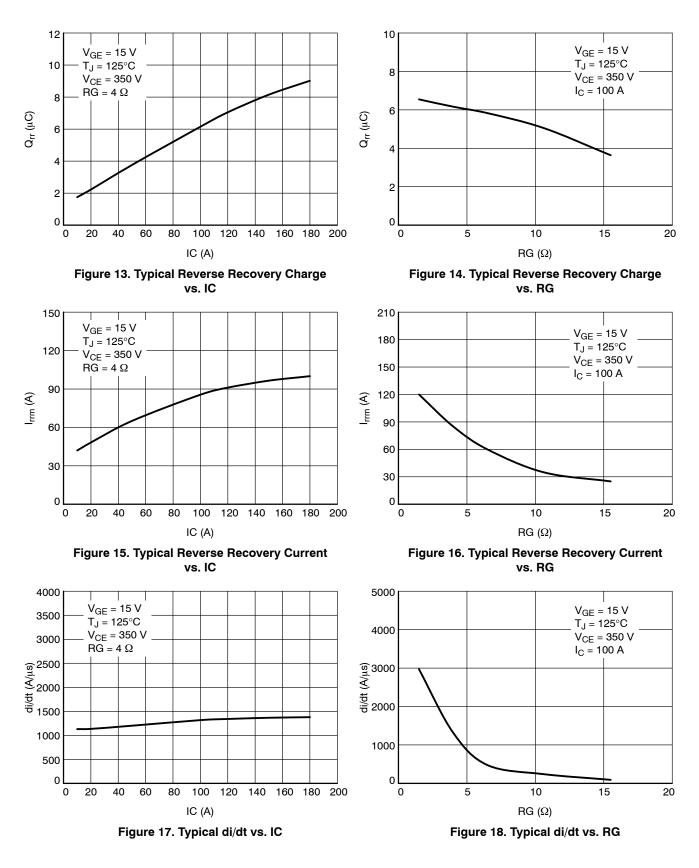
Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
HALFBRIDGE IGBT INVERSE DIODE (D1	, D4) CHARACTERISTICS					
Forward voltage	I_F = 7 A, T_j = 25°C I_F = 7 A, T_j = 125°C	V _F	-	1.46 1.49	2.7	V
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil \pm 2%, λ = 1 W/mK	R _{thJH}		1.864		°C/W
HALFBRIDGE IGBT (T1, T4) CHARACTE	RISTICS					
Collector-emitter saturation voltage	V_{GE} = 15 V, I _C = 160 A, T _j = 25°C V _{GE} = 15 V, I _C = 160 A, T _j = 125°C	V _{CE(sat)}	-	2.06 2.10	2.50 _	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}, I_C = 6 \text{ mA}$	V _{GE(TH)}	5.0	5.80	6.50	V
Collector-emitter cutoff current	V_{GE} = 0 V, V_{CE} = 1200 V	I _{CES}	_	-	800	μΑ
Gate leakage current	V_{GE} = 20 V, V_{CE} = 0 V	I _{GES}	_	-	800	nA
Turn–on delay time	T _j = 125°C	t _{d(on)}	_	55	-	ns
Rise time	$V_{CE} = 350 \text{ V}, \text{ I}_{C} = 100 \text{ A}$	t _r	-	50	-	
Turn-off delay time	V_{GE} = ±15 V, R_{G} = 4 Ω	t _{d(off)}		430	_	
Fall time		t _f	1	105	_	
Turn on switching loss		Eon		2.73	_	mJ
Turn off switching loss		E _{off}	1	3.58	-	
Input capacitance	V_{CE} =25 V. V_{GE} = 0 V. f = 10 kHz	C _{ies}	-	38164	-	pF
Output capacitance		C _{oes}	_	644	-	
Reverse transfer capacitance		C _{res}	-	784	-	
Gate charge total	V_{CE} = 600 V, I_{C} = 160 A, V_{GE} = 15 V	Qg	_	1664	-	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil \pm 2%, λ = 1 W/mK	R _{thJH}		0.337		°C/W
NP DIODE (D6, D7) CHARACTERISTICS						•
Forward voltage	V_{GE} = 0 V, I _F = 150 A, T _j = 25°C V _{GE} = 0 V, I _F = 150 A, T _j = 125°C	V _F	-	2.15 2.36	2.60	V
Reverse leakage current	V_{CE} = 650 V, V_{GE} = 0 V	lr	1	-	200	μΑ
Reverse recovery time	T _j = 125°C	trr		225	_	ns
Reverse recovery charge	$V_{CE} = 350 \text{ V}, \text{ I}_{C} = 100 \text{ A}$	Qrr	1	6.15	-	μC
Peak reverse recovery current	V_{GE} = ±15 V, R_{G} = 4 Ω	Irrm	_	85	-	А
Peak rate of fall of recovery current		di/dtmax	-	1315	_	A/μs
Reverse recovery energy		Err	-	1.336	_	mJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil \pm 2%, λ = 1 W/mK	RthJH	_	1.07		°C/W

Table 2. ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
NP IGBT (T2, T3)						
Collector-emitter saturation voltage	V_{CE} = 15 V, I _C = 150 A, T _j = 25°C V _{CE} = 15 V, I _C = 150 A, T _j = 125°C	V _{CE(sat)}	_	1.65 1.84	2.0	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 8 \text{ mA}$	V _{GE(TH)}	5.0	6.10	6.90	V
Collector-emitter cutoff current	V_{GE} = 0 V, V_{CE} = 650 V	I _{CES}		_	400	μA
Gate leakage current	V_{GE} = 20 V, V_{CE} = 0 V	I _{GES}	ĺ	_	800	nA
Turn-on delay time	T _j = 125°C	t _{d(on)}	-	46	_	ns
Rise time	$V_{CE} = 350 \text{ V}, \text{ I}_{C} = 100 \text{ A}$	t _r	ĺ	48	_	
Turn–off delay time	V_{GE} = ±15 V, R_{G} = 4 Ω	t _{d(off)}	ĺ	250	_	
Fall time		t _f		105	-	
Turn on switching loss		E _{on}		1.245	_	mJ
Turn off switching loss		E _{off}	_	2.525	_	
Input capacitance	V _{CE} = 25 V, V _{GE} = 0 V, f = 10 kHz	C _{ies}	_	19380	_	pF
Output capacitance		C _{oes}	_	570	_	
Reverse transfer capacitance		C _{res}	_	496	_	
Gate charge total	V_{CE} = 480 V, I _C = 150 A, V _{GE} = 15 V	Qg	_	790	_	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil \pm 2%, λ = 1 W/mK	R _{thJH}	_	0.81	_	°C/W
NP INVERSE DIODE (D2, D3)						
Forward voltage	V_{GE} = 0 V, I _F = 15 A, T _j = 25°C V _{GE} = 0 V, I _F = 15 A, T _j = 125°C	V _F	_	1.60 1.59	2.20	V
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil \pm 2%, λ = 1 W/mK	R _{thJH}		3.43		°C/W
HALFBRIDGE DIODE (D5, D8)						
Forward voltage	V _{GE} = 0 V, I _F = 150 A, T _j = 25°C V _{GE} = 0 V, I _F = 150 A, T _j = 125°C	V _F	-	2.50 2.80	3.50 _	V
Reverse leakage current	V _{CE} = 1200 V, V _{GE} = 0 V	lr	_	-	200	μΑ
Reverse recovery time	T _j = 125°C	trr	_	405	_	ns
Reverse recovery charge	$V_{CE} = 350 \text{ V}, \text{ I}_{C} = 100 \text{ A}$	Qrr	_	15.5	_	μC
Peak reverse recovery current	V_{GE} = ±15 V, R_{G} = 4 Ω	Irrm	_	220	_	А
Peak rate of fall of recovery current		di/dtmax	_	5440	_	A/μs
Reverse recovery energy		Err	_	5.225	_	mJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil \pm 2%, λ = 1 W/mK	RthJH	_	1.213	-	°C/W
THERMISTOR CHARACTERISTICS				•		•
Nominal resistance		R ₂₅	-	22	-	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	-	1486	-	Ω
Deviation of R25		DR/R	-5	-	5	%
Power dissipation		PD	_	200	-	mW
Power dissipation constant			_	2	-	mW/K
B-value	B(25/50), tol ±3%		-	3950	-	К
B-value	B(25/100), tol ±3%		_	3998	_	К







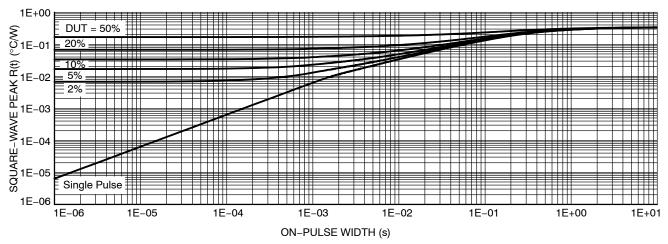


Figure 19. Transient Thermal Impedance (Half Bridge IGBT)

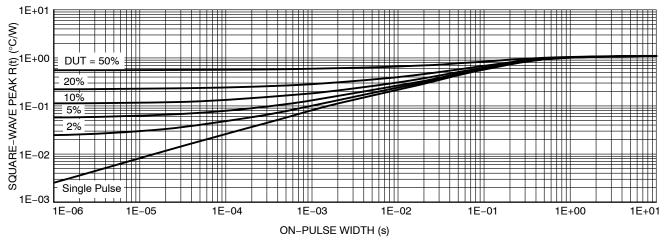
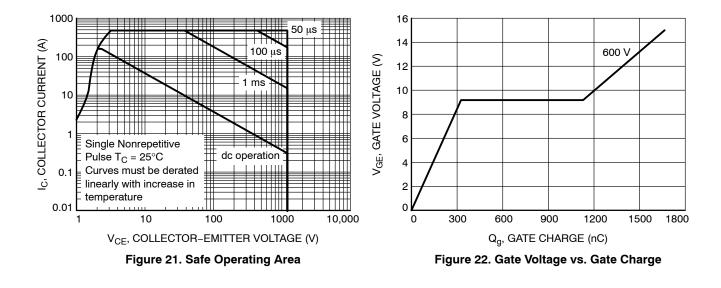
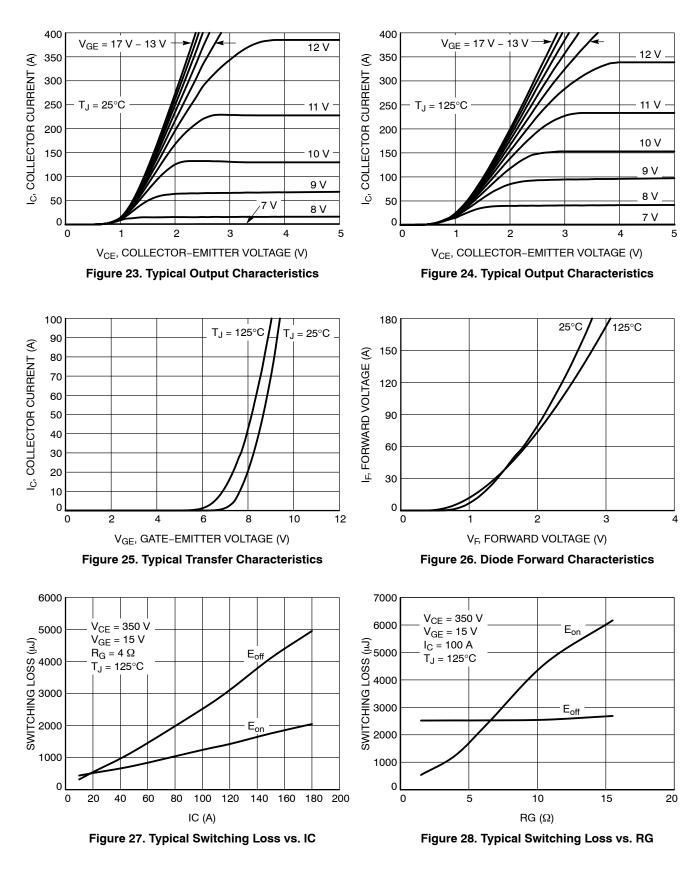
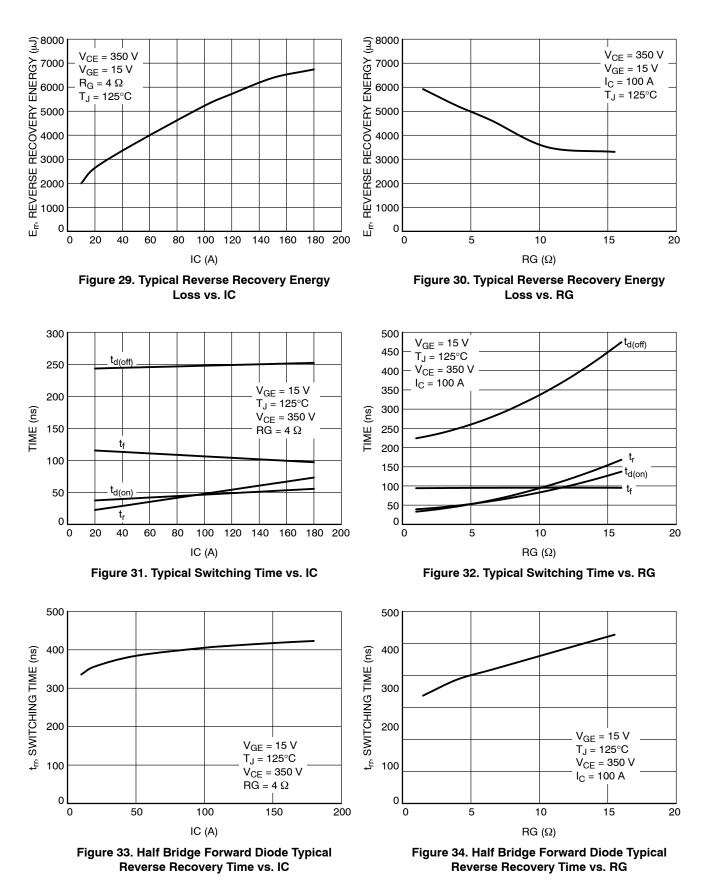
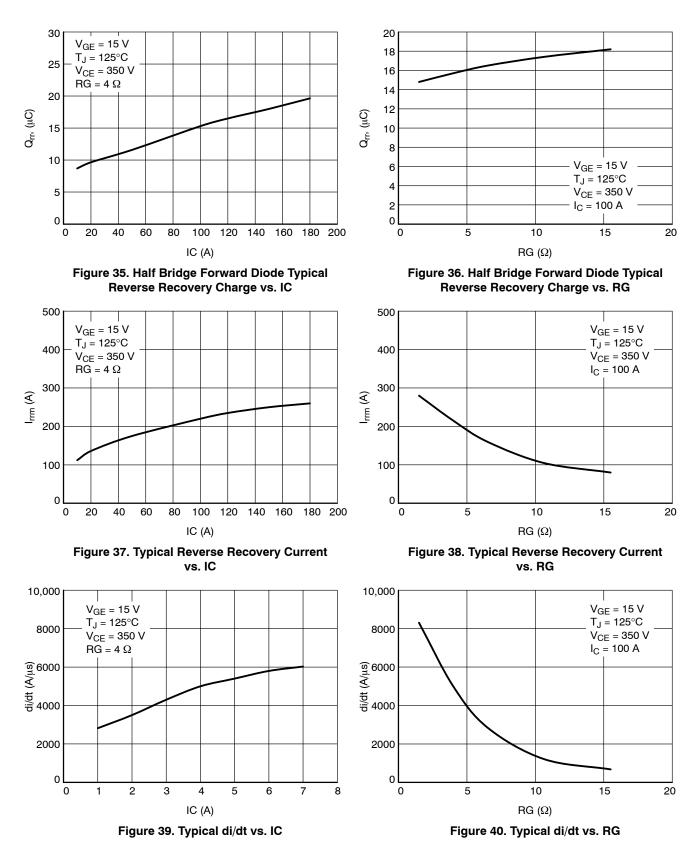


Figure 20. Transient Thermal Impedance (Neutral Point Forward Diode)









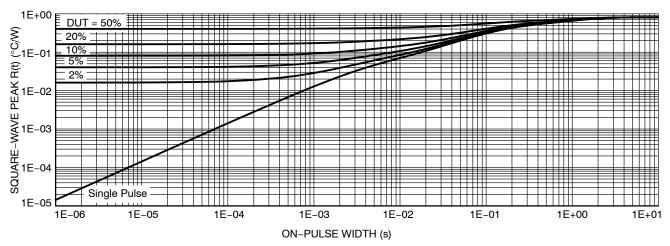


Figure 41. Transient Thermal Impedance (Neutral Point IGBT)

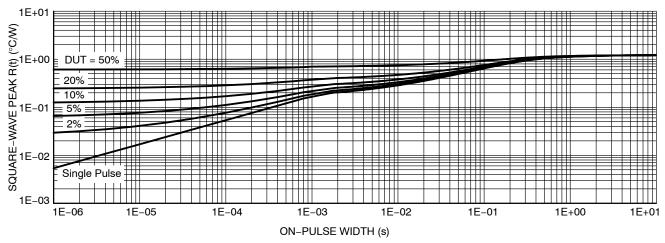
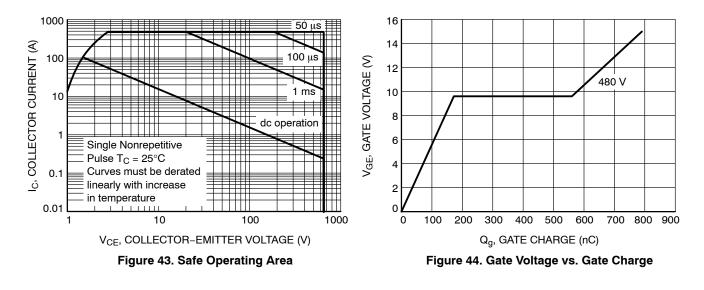


Figure 42. Transient Thermal Impedance (Half Bridge Forward Diode)



TYPICAL CHARACTERISTICS – HALF BRIDGE INVERSE DIODE

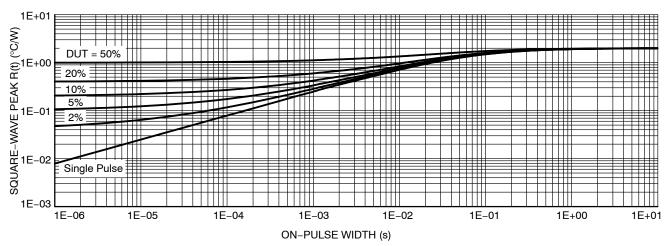


Figure 45. Transient Thermal Impedance

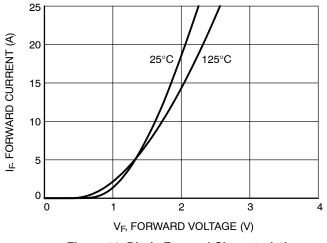
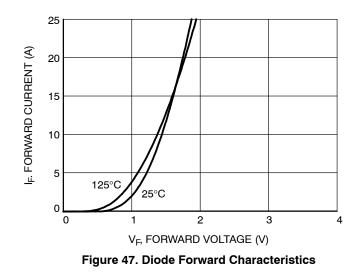
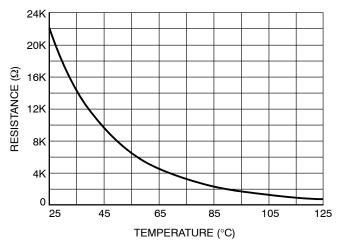


Figure 46. Diode Forward Characteristics

TYPICAL CHARACTERISTICS – NEUTRAL POINT INVERSE DIODE



TYPICAL CHARACTERISTICS – THERMISTOR

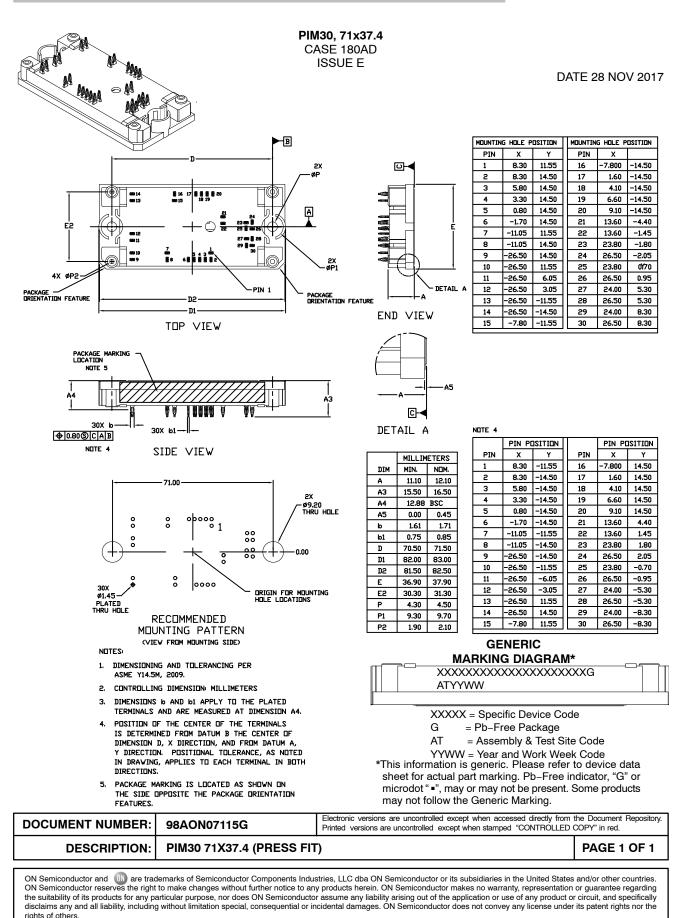




ORDERING INFORMATION

Orderable Part Number	Package	Shipping
NXH160T120L2Q1PG (Press Fit)	Q1PACK – Case 180AD (Pb-Free and Halide-Free)	21 Units / Blister Tray
NXH160T120L2Q1SG (Solder Pin)	Q1PACK – Case 180AQ (Pb-Free and Halide-Free)	21 Units / Blister Tray





MOUNTING HOLE POSITION

¥

7.800

1.60

4.10

6.60

9.10 -14.50

13.60

13.60

23.80

26.50

23.80

26.50

24.00

26.50

24.00

26.50

х

-7.800

1.60

4.10

6.60

9.10

13.60

13.60

23.80

26.50

23.80

26 50

24.00

26.50

24.00

26.50 -8.30

PIN POSITION

Y

14.50

-14.50

-14.50

-14.50

-4.40

-1.45

-1.80

-2.05

0.70

0.95

5.30

5.30

8.30

8.30

Y

14.50

14.50

14.50

14.50

14.50

4.40

1.45

1.80

2.05

-0.70

-0.95

-5.30

-5.30

-8.30

PIN

16

17

18

19

20

21

22

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PIN

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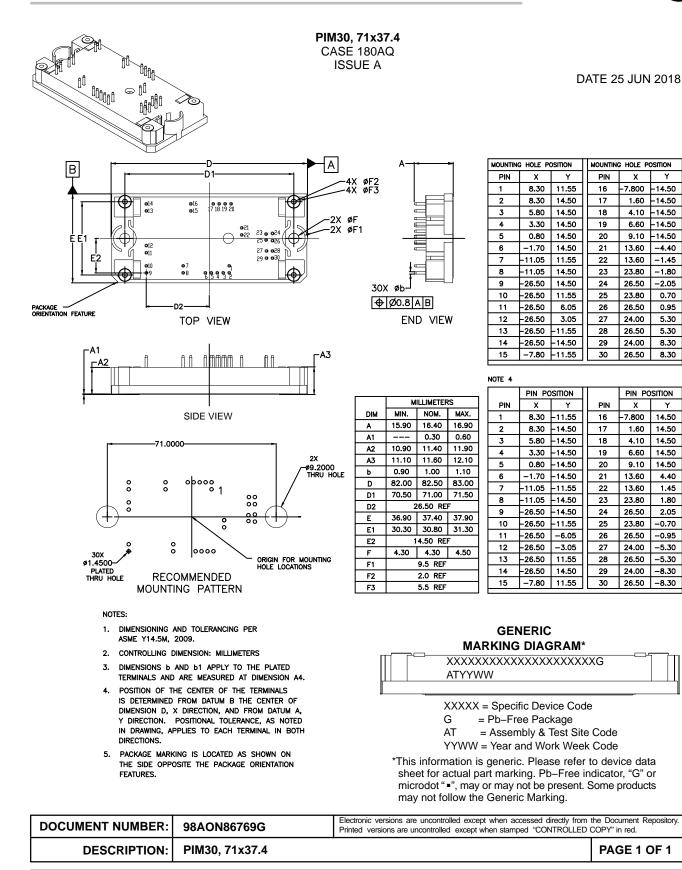
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PAGE 1 OF 1

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